

General Description

The AAT8303 is a low threshold P-channel MOS-FET designed for the battery, cell phone, and PDA markets. Using AnalogicTech's proprietary ultrahigh-density trench technology and space-saving, small-outline, J-lead package, performance superior to that normally found in a larger footprint has been squeezed into the area of a TSOPJW-8 package.

Applications

- Battery Packs
- Battery-Powered Portable Equipment
- Cellular and Cordless Telephones
- Load Switches

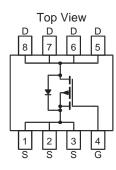
Absolute Maximum Ratings

 $T_A = 25^{\circ}C$, unless otherwise noted.

Features

- Drain-Source Voltage (max): -20V
- Continuous Drain Current¹ (max): -10A @ 25°C
- Low On-Resistance:
 - 14mΩ @ V_{GS} = -4.5V
 - 24m Ω @ V_{GS} = -2.5V

TSOPJW-8 Package



Symbol	Description	Value	Units	
V _{DS}	Drain-Source Voltage		-20	V
V _{GS}	Gate-Source Voltage	±12	v	
	Continuous Drain Current @ $T_J = 150^{\circ}C^{1}$	$T_A = 25^{\circ}C$	±10	
Ι _D		$T_A = 70^{\circ}C$	±8	А
I _{DM}	Pulsed Drain Current ²	±48	A	
I _S	Continuous Source Current (Source-Drain Diode) ¹	-2.3		
TJ	Operating Junction Temperature Range	-55 to 150	°C	
T _{STG}	Storage Temperature Range	-55 to 150	°C	

Thermal Characteristics¹

Symbol	Description		Тур	Max	Units	
R _{θJA}	Junction-to-Ambient Steady State		86	105	°C/W	
R _{0JA2}	Junction-to-Ambient t<5 Seconds		44	54	°C/W	
R _{0JF}	Junction-to-Foot		27	32	°C/W	
Р	Maximum Power Dissipation	$T_A = 25^{\circ}C$		2.3	W	
PD		$T_A = 70^{\circ}C$		1.5	vv	

^{1.} Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.



Electrical Characteristics

 $T_J = 25^{\circ}C$, unless otherwise noted.

Symbol	Description	Conditions	Min	Тур	Мах	Units	
DC Chara	DC Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = -250 \mu A$	-20			V	
R _{DS(ON)}	Drain-Source On-Resistance ¹	$V_{GS} = -4.5V, I_D = -10A$ $V_{GS} = -2.5V, I_D = -7.6A$		11 18	14 24	mΩ	
I _{D(ON)}	On-State Drain Current ¹	$V_{GS} = -4.5V, V_{DS} = -5V$ (pulsed)	-48			А	
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-0.6			V	
I _{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA	
I _{DSS}	Drain Source Leakage Current	$V_{GS} = 0V, V_{DS} = -20V$ $V_{GS} = 0V, V_{DS} = -16V, T_{J} = 70^{\circ}C^{2}$			-1 -5	μA	
g _{fs}	Forward Transconductance ¹	$V_{\rm DS} = -5V, I_{\rm D} = -10A$		31		S	
Dynamic	Characteristics ²						
Q _G	Total Gate Charge	$V_{DS} = -10V, R_{D} = 1.0\Omega, V_{GS} = -4.5V$		36			
Q _{GS}	Gate-Source Charge	$V_{DS} = -10V, R_{D} = 1.0\Omega, V_{GS} = -4.5V$		5		nC	
Q _{GD}	Gate-Drain Charge	$V_{DS} = -10V, R_{D} = 1.0\Omega, V_{GS} = -4.5V$		13			
t _{D(ON)}	Turn-On Delay	V_{DS} = -10V, V_{GS} = -4.5V, R_D = 1.0 Ω , R_G = 6 Ω		10			
t _R	Turn-On Rise Time	V_{DS} = -10V, V_{GS} = -4.5V, R_D = 1.0 Ω , R_G = 6 Ω		72		ns	
t _{D(OFF)}	Turn-Off Delay	$V_{DS} = -10V, V_{GS} = -4.5V, R_{D} = 1.0\Omega, R_{G} = 6\Omega$		78		115	
t _F	Turn-Off Fall Time	V_{DS} = -10V, V_{GS} = -4.5V, R_D = 1.0 Ω , R_G = 6 Ω		108			
Source-Drain Diode Characteristics							
V _{SD}	Source-Drain Forward Voltage ¹	V _{GS} = 0, I _S = -10A			-1.1	V	
۱ _s	Continuous Diode Current ³				-2.3	А	

1. Pulse test: Pulse Width = 300μ s.

2. Guaranteed by design. Not subject to production testing.

^{3.} Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.



Transfer Characteristics

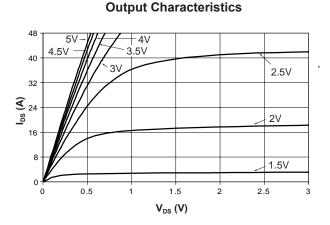
48

40

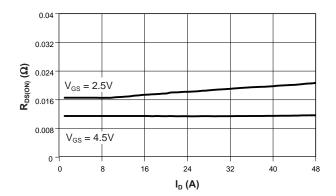
V_D=V_G

Typical Characteristics

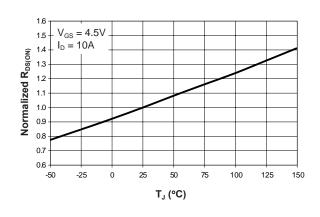
 $T_J = 25^{\circ}C$, unless otherwise noted.

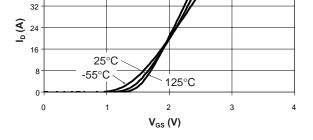


On-Resistance vs. Drain Current

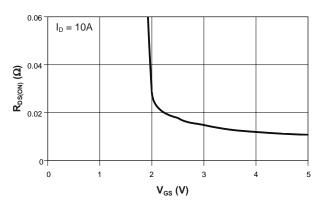


On-Resistance vs. Junction Temperature

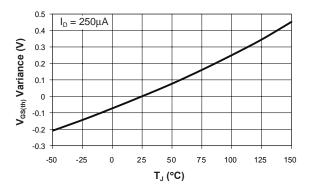




On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



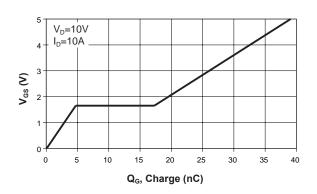


AAT8303 20V P-Channel Power MOSFET

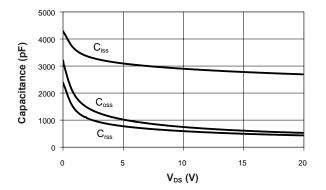
Typical Characteristics

 $T_{\rm J} = 25^{\circ}$ C, unless otherwise noted.

Gate Charge



Capacitance

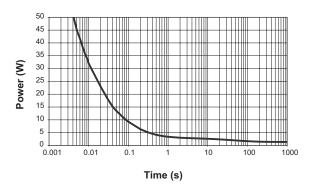


Single Pulse Power, Junction to Ambient

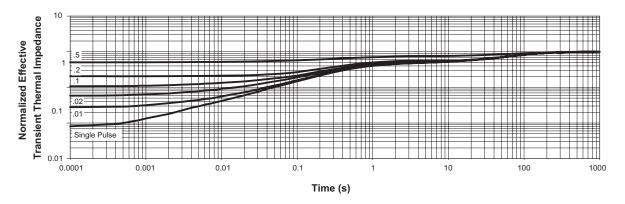
0.6

V_{SD} (V)

0.8







Source-Drain Diode Forward Voltage

 $T_J = 150^{\circ}C$

0.4

0.2

 $T_J = 25^{\circ}C$

1

. 1.2

100

10

0.1

0

I_s (A)

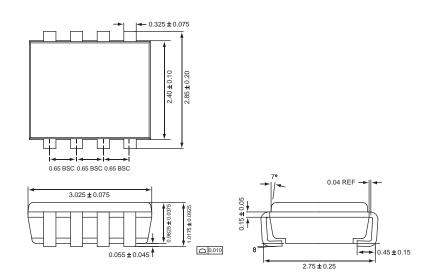


Ordering Information

Package	Marking ¹	Part Number (Tape and Reel) ²
TSOPJW-8	JXXYY	AAT8303ITS-T1

Package Information

TSOPJW-8



All dimensions in millimeters.

1. XYY = assembly and date code.

2. Sample stock is generally held on part numbers listed in BOLD.



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Advanced Analogic Technologies, Inc. 830 E. Arques Avenue, Sunnyvale, CA 94085 Phone (408) 737-4600 Fax (408) 737-4611

